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FAIRCHILD

SEMICONDUCTOR ™

Si4835DY

P-Channel Logic Level PowerTrench® MOSFET

General Description

This P-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Applications

- Battery protection
- Load switch
- Motor drives

Features

- -8.8 A, -30 V. $R_{DS(ON)}$ = 0.020 Ω @ V_{GS} = -10 V

  $R_{DS(ON)}$ = 0.035 Ω @ V_{GS} = -4.5 V

- Extended V_{GSS} range ($\pm$25V) for battery applications.

- Low gate charge (19nC typical).

- Fast switching speed.

- High performance trench technology for extremely low $R_{DS(ON)}$.

- High power and current handling capability.

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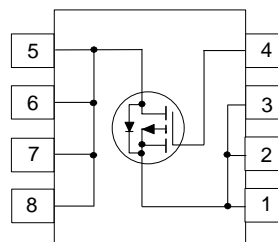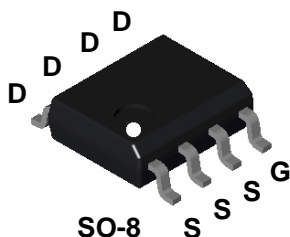
Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		-30	V
V_{GSS}	Gate-Source Voltage		±25	V
I_D	Drain Current - Continuous	(Note 1a)	-8.8	A
	- Pulsed		-50	
P_D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T_J, T_{stg}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Outlines and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
Si4835DY	4835	13"	12mm	2500 units

Si4835DY Rev. A

Electrical Characteristics T_A = 25°C unless otherwise noted

| Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = -250 μA	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, Referenced to 25°C		-24		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = -24 V, V_{GS} = 0 V			-1	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 25 V, V_{DS} = 0 V			100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -25 V, V_{DS} = 0 V			-100	nA
On Characteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = -250 μA	-1	-2	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μA, Referenced to 25°C		5		mV/°C
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = -10 V, I_D = -8.8 A V_{GS} = -10 V, I_D = -8.8 A, T_J=125°C V_{GS} = -4.5 V, I_D = -6.7 A		0.015 0.023 0.026	0.020 0.032 0.035	Ω
$I_{D(on)}$	On-State Drain Current	V_{GS} = -10 V, V_{DS} = -5 V	-25			A
g_{FS}	Forward Transconductance	V_{DS} = -10 V, I_D = -8.8 A		20		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = -15 V, V_{GS} = 0 V, f = 1.0 MHz		1680		pF
C_{oss}	Output Capacitance			545		pF
C_{rss}	Reverse Transfer Capacitance			220		pF
Switching Characteristics (Note 2)						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = -15 V, I_D = -1 A, V_{GS} = -10 V, R_{GEN} = 6 Ω		12	22	ns
t_r	Turn-On Rise Time			15	27	ns
$t_{d(off)}$	Turn-Off Delay Time			55	90	ns
t_f	Turn-Off Fall Time			23	37	ns
Q_g	Total Gate Charge	V_{DS} = -10 V, I_D = -8.8 A, V_{GS} = -5 V,		19	27	nC
Q_{gs}	Gate-Source Charge			6.8		nC
Q_{gd}	Gate-Drain Charge			7.2		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current				-2.1	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = -2.1 A (Note 2)		-0.52	-1.2	V

Notes:

1: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.

a) 50° C/W when mounted on a 1 in² pad of 2 oz. copper.
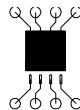
b) 105° C/W when mounted on a 0.04 in² pad of 2 oz. copper.
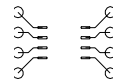
c) 125° C/W on a minimum mounting pad of 2 oz. copper.

Scale 1 : 1 on letter size paper

2: Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%
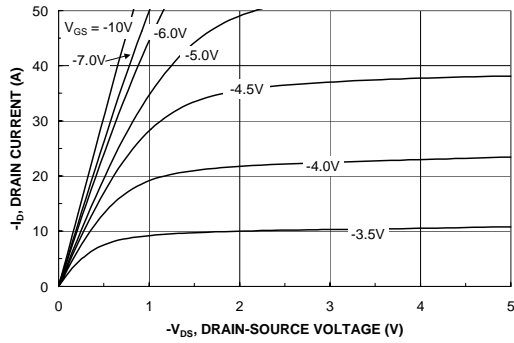
Typical Characteristics
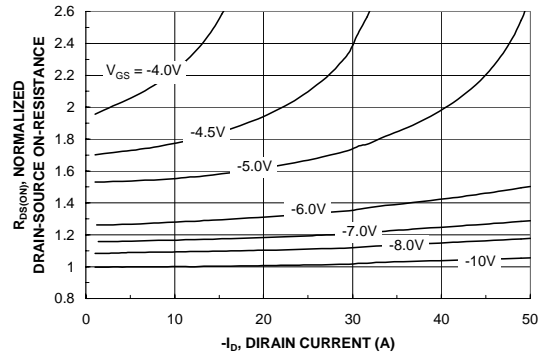
Figure 1. On-Region Characteristics

Figure 2. On-Resistance Variation
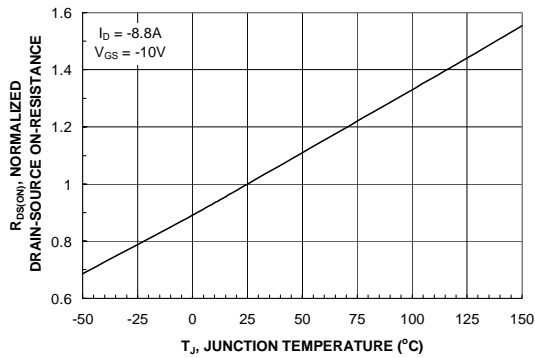with Drain Current and Gate Voltage

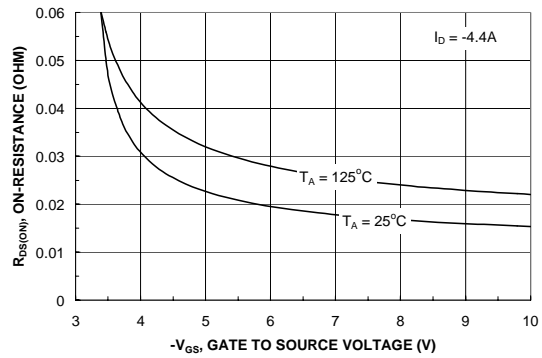Figure 3. On-Resistance Variation
with Temperature

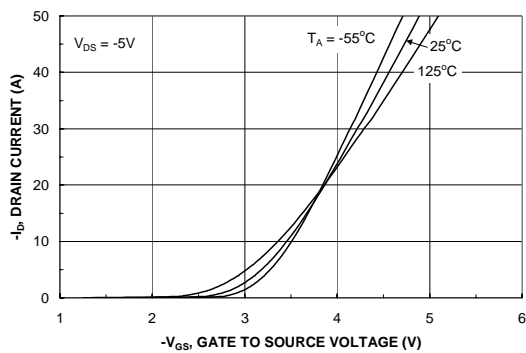Figure 4. On-Resistance Variation
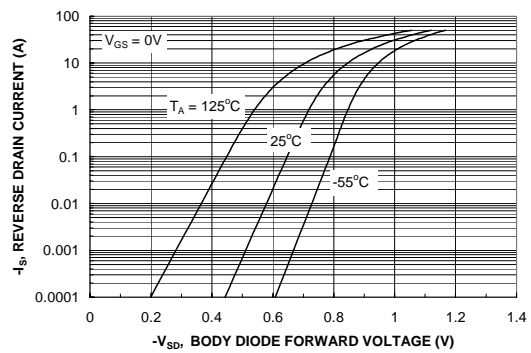with Gate-to-Source Voltage

Figure 5. Transfer Characteristics

Figure 6. Body Diode Forward Voltage
Variation with Source Current
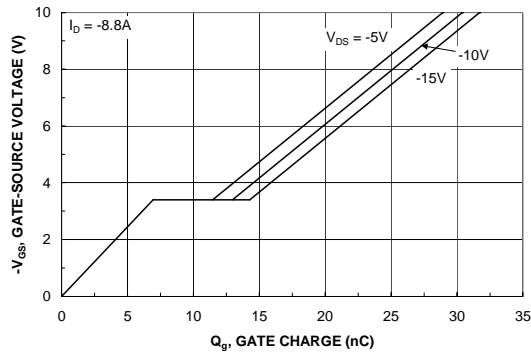and Temperature

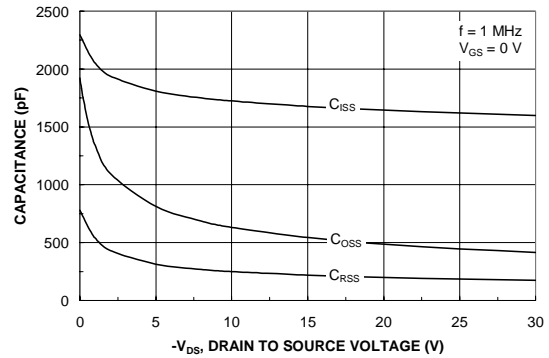## Typical Characteristics (continued)

Figure 7. Gate-Charge Characteristics
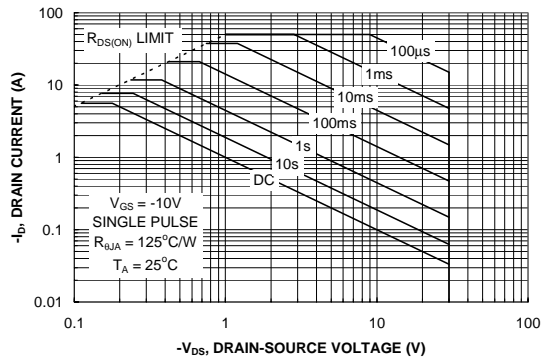

Figure 8. Capacitance Characteristics

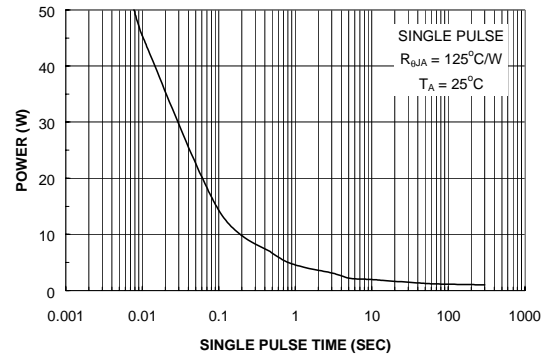

Figure 9. Maximum Safe Operating Area

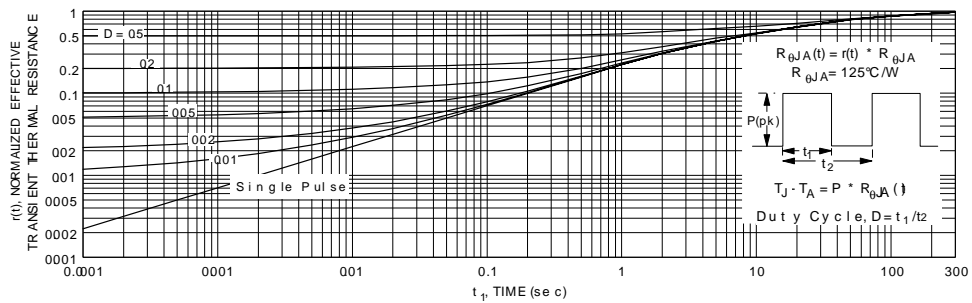**Figure 10. Single Pulse Maximum Power Dissipation**

Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.

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DOME™	ISOPLANAR™	Quiet Series™	
E²CMOS™	MICROWIRE™	SILENT SWITCHER ®	
EnSigna™	OPTOLOGIC™	SMART START™	
FACT™	OPTOPLANAR™	SuperSOT™-3	
FACT Quiet Series™	PACMAN™	SuperSOT™-6	
FAST ®	POP™	SuperSOT™-8	

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

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